Form PTO 1489
(Modified)DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
247532US0XDIVSERIAL NO.
10/756,406



LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Tatsuya TOMIOKA, et al.

FILING DATE
January 14, 2004GROUP
1772

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	4,469,561	09/04/1984	S. K. SIKDAR, et al.			
	AB	5,959,160	09/28/1999	C. WULFF, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
DB	AO	0 511 640	11/04/1992	EUROPE		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

David A. Miller

Date Considered

7/5/05

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 247532US0XDIV		SERIAL NO. New application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Tatsuya TOMIOKA, et al.			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
OB ↓	AA	5,785,823	07-98	Meurer et al			
	AB	5,215,799	06-93	Sakoda			
	AC	6,022,943	02-08-00	Inoue et al			
	AD						
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	AN						
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION			
				YES	NO		
OB	AO	8-73724	03-19-96	Japan	x		
	AP	2000-63505	02-20-00	Japan (200-328076) (English Abstract Only)		X	
	AO	7-26700	01-27-95	Japan (00-202786) (English Abstract Only)		X	
	AP	6-48970	02-33-94	Japan (07-123892) (English Abstract Only)		X	
OB OB OB OB	AS	2000-229899	08-22-00	Japan (Tetsuya) (English Abstract Only)		X	
	AT	2000-001608	01-00	Japan (Masaaki)	x		
	AU	0 947 538	10-06-99	Europe	x		
	AV	0 592 900	04-20-94	Europe	x		
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
				<input type="checkbox"/> Additional References sheet(s) attached			
Examiner <u>Daniel R. Sutton</u>				Date Considered <u>7/5/05</u>			
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

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	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
1	DB	AO 0 615 996 ✓	09-21-94	Europe	x		
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>David B. Sutton</i>					Date Considered <i>7/5/05</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							